

| Search Notes (continued)   | Application/Control No. | Applicant(s)/Patent under Reexamination |
|--|-------------------------|---|
|  | 10/532,921              | HATADE ET AL.                           |
|  | Examiner                | Art Unit                                |
|  | James Phan              | 2872                                    |

**SEARCHED**

| INTERFERENCE SEARCHED |          |      |          |
|-----------------------|----------|------|----------|
| Class                 | Subclass | Date | Examiner |
|                       |          |      |          |
|                       |          |      |          |
|                       |          |      |          |
|                       |          |      |          |
| See "Search Notes"    |          | 5/07 | W.P.     |